

FCC Part 15C Measurement and Test Report

For

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FCC ID: YZVVR-651B

FCC Rule(s):	FCC Part 15.247		
Product Description:	Car Radio		
Tested Model:	<u>VR-651B</u>		
Report No.:	STR160382201		
Tested Date:	2016-04-05 to 2016-04-12		
Issued Date:	<u>2016-04-12</u>	1 1	
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1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

SHENZHEN TOKWA PRECISION TECHNOLOGY
CO., LTD.
4th Floor, Block A, Zhengfeng Industrial Park,
Fengtang Road, Fuyong, Baoan District, Shenzhen,
China
SHENZHEN TOKWA PRECISION TECHNOLOGY
CO., LTD.
4th Floor, Block A, Zhengfeng Industrial Park,
Fengtang Road, Fuyong, Baoan District, Shenzhen,
China

General Description of EUT	
Product Name:	Car Radio
Trade Name:	/
Model No.:	VR-651B
	VIR-7830B, PTID-8920B, TI-651B, VR-XXB(X=0-9),
Adding Model(s):	PD-XXXB(X=0-9), VR-XXXB(X=0-9)
Rated Voltage:	DC12-24V
	•

Note: The test data is gathered from a production sample provided by the manufacturer. The appearance of others models listed in the report is different from main-test model VR-651B, but the circuit and the electronic construction do not change, declared by the manufacturer.

Technical Characteristics of EUT	
Bluetooth Version:	V3.0
Frequency Range:	2402-2480MHz
RF Output Power:	-1.833dBm (Conducted)
Data Rate:	1Mbps, 2Mbps, 3Mbps
Modulation:	GFSK, Pi/4 QDPSK, 8DPSK
Quantity of Channels:	79
Channel Separation:	1MHz
Type of Antenna:	PCB
Antenna Gain:	0dBi
Lowest Internal Frequency of EUT:	8MHz



1.2 Test Standards

The following report is prepared on behalf of the SHENZHEN TOKWA PRECISION TECHNOLOGY CO., LTD. in accordance with FCC Part 15, Subpart C, and section 15.203, 15.205, 15.207, 15.209 and 15.247 of the Federal Communication Commissions rules.

The objective is to determine compliance with FCC Part 15, Subpart C, and section 15.203, 15.205, 15.207, 15.209 and 15.247 of the Federal Communication Commissions rules.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.10-2013, American National Standard for Testing Unlicensed Wireless Devices, and ANSI C63.4-2014, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz. The measurement guide DA 00-705 for frequency hopping spread spectrum systems shall be performed also.

1.4 Test Facility

FCC – Registration No.: 934118

Shenzhen SEM.Test Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files and the Registration is 934118.

Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Shenzhen SEM.Test Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

CNAS Registration No.: L4062

Shenzhen SEM.Test Technology Co., Ltd. is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L4062. All measurement facilities used to collect the measurement data are located at 1/F, Building A, Hongwei Industrial Park, Liuxian 2nd Road, Bao'an District, Shenzhen, P.R.C (518101).



1.5 EUT Setup and Test Mode

The EUT was operated in the engineering mode to fix the Tx frequency that was for the purpose of the measurements. All testing shall be performed under maximum output power condition, and to measure its highest possible emissions level, more detailed description as follows:

Test Mode List				
Test Mode	Description	Remark		
TM1	Low Channel	2402MHz		
TM2	Middle Channel	2441MHz		
TM3	High Channel	2480MHz		
TM4	Hopping	2402-2480MHz		

Modulation Configure			
Modulation	Packet	Packet Type	Packet Size
	DH1	4	27
GFSK	DH3	11	183
	DH5	15	339
Pi/4 DQPSK	2DH1	20	54
	2DH3	26	367
	2DH5	30	379
	3DH1	24	83
8DPSK	3DH3	27	552
	3DH5	31	1021

Normal mode: the Bluetooth has been tested on the modulation of GFSK, (Pi/4)DQPSK and 8DPSK, compliance test and record the worst case.

EUT Cable List and Details				
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite	
/	/	/	/	

Special Cable List and Details					
Cable Description Length (m) Shielded/Unshielded With / Without Ferrite					
/	/	/	/		

Auxiliary Equipment List and Details				
Description Manufacturer Model Serial Number				
/	/	/	/	



1.6 Measurement Uncertainty

Measurement uncertainty				
Parameter	Conditions	Uncertainty		
RF Output Power	Conducted	± 0.42 dB		
Occupied Bandwidth	Conducted	$\pm 1.5\%$		
Conducted Emissions	Conducted	± 2.88 dB		
Transmitter Spurious Emissions	Radiated	± 5.1 dB		
Transmitter Spurious Emissions	Conducted	± 0.42 dB		

1.7 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal Date	Due Date
Spectrum Analyzer	Agilent	E4407B	MY41440400	2015-06-17	2016-06-16
Spectrum Analyzer	Rohde & Schwarz	FSP	836079/035	2015-06-17	2016-06-16
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2015-06-17	2016-06-16
Amplifier	Agilent	8447F	3113A06717	2015-06-17	2016-06-16
Amplifier	C&D	PAP-1G18	2002	2015-06-17	2016-06-16
Broadband Antenna	Schwarz beck	VULB9163	9163-333	2015-06-17	2016-06-16
Horn Antenna	ETS	3117	00086197	2015-06-17	2016-06-16
Horn Antenna	Schwarzbeck	BBHA 9170	BBHA9170582	2015-06-17	2016-06-16
Loop Antenna	Schwarz beck	FMZB 1516	9773	2015-06-17	2016-06-16
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2015-06-17	2016-06-16
L.I.S.N	Schwarz beck	NSLK8126	8126-224	2015-06-17	2016-06-16
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2015-06-17	2016-06-16



2. SUMMARY OF TEST RESULTS

FCC Rules	Description of Test Item	Result
§ 2.1093	RF Exposure	Compliant
§ 15.203; § 15.247(b)(4)(i)	Antenna Requirement	Compliant
§15.205	Restricted Band of Operation	Compliant
§ 15.207(a)	Conducted Emission	N/A
§ 15.209(a)	Radiated Spurious Emissions	Compliant
§ 15.247(a)(1)(iii)	Quantity of Hopping Channel	Compliant
§ 15.247(a)(1)	Channel Separation	Compliant
§ 15.247(a)(1)(iii)	Time of Occupancy (Dwell time)	Compliant
§ 15.247(a)	20dB Bandwidth	Compliant
§ 15.247(b)(1)	RF Power Output	Compliant
§ 15.247(d)	Band Edge (Out of Band Emissions)	Compliant
§ 15.247(a)(1)	Frequency Hopping Sequence	Compliant
§ 15.247(g), (h)	Frequency Hopping System	Compliant

N/A: not applicable



3. RF Exposure

3.1 Standard Applicable

According to § 1.1307 and § 2.1093, the portable transmitter must comply the RF exposure requirements.

3.2 Test Result

This product complied with the requirement of the RF exposure, please see the RF Exposure Report.



4. Antenna Requirement

4.1 Standard Applicable

According to FCC Part 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

4.2 Evaluation Information

This product has a PCB antenna, fulfill the requirement of this section.



5. Frequency Hopping System Requirements

5.1 Standard Applicable

According to FCC Part 15.247(a)(1), The system shall hop to channel frequencies that are selected at the system hopping rate from a pseudo randomly ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

(g) Frequency hopping spread spectrum systems are not required to employ all available hopping channels during each transmission. However, the system, consisting of both the transmitter and the receiver, must be designed to comply with all of the regulations in this section should the transmitter be presented with a continuous data (or information) stream. In addition, a system employing short transmission bursts must comply with the definition of a frequency hopping system and must distribute its transmissions over the minimum number of hopping channels specified in this section.

(h) The incorporation of intelligence within a frequency hopping spread spectrum system that permits the system to recognize other users within the spectrum band so that it individually and independently chooses and adapts its hopsets to avoid hopping on occupied channels is permitted. The coordination of frequency hopping systems in any other manner for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters is not permitted.

5.2 Frequency Hopping System

This transmitter device is frequency hopping device, and complies with FCC part 15.247 rule.

This device uses Bluetooth radio which operates in 2400-2483.5 MHz band. Bluetooth uses a radio technology called frequency-hopping spread spectrum, which chops up the data being sent and transmits chunks of it on up to 79 bands (1 MHz each; centred from 2402 to 2480 MHz) in the range 2,400-2,483.5 MHz. The transmitter switches hop frequencies 1,600 times per second to assure a high degree of data security. All Bluetooth devices participating in a given piconet are synchronized to the frequency-hopping channel for the piconet. The frequency hopping sequence is determined by the master's device address and the phase of the hopping sequence (the frequency to hop at a specific time) is determined by the master's internal clock. Therefore, all slaves in a piconet must know the master's device address and must synchronize their clocks with the master's clock.

Adaptive Frequency Hopping (AFH) was introduced in the Bluetooth specification to provide an effective way for a Bluetooth radio to counteract normal interference. AFH identifies "bad" channels, where either other wireless devices are interfering with the Bluetooth signal or the Bluetooth signal is interfering with another device. The AFH-enabled Bluetooth device will then communicate with other devices within its piconet to share details of any identified bad channels. The devices will then switch to alternative available "good" channels, away from the areas of interference, thus having no impact on the bandwidth used.

This device was tested with an bluetooth system receiver to check that the device maintained hopping synchronization, and the device complied with these requirements for DA 00-705 and FCC Part 15.247 rule.

5.3 EUT Pseudorandom Frequency Hopping Sequence

Pseudorandom Frequency Hopping Sequence Table as below:

Channel: 08, 24, 40, 56, 40, 56, 72, 09, 01, 09, 33, 41, 33, 41, 65, 73, 53, 69, 06, 22, 04, 20, 36, 52, 38, 46, 70, 78, 68, 76, 21, 29, 10, 26, 42, 58, 44, 60, 76, 13, 03, 11, 35, 43, 37, 45, 69, 77, 55, 71, 08, 24, 08, 24, 40, 56, 40, 48, 72, 01, 72, 01, 25, 33, 12, 28, 44, 60, 42, 58, 74, 11, 05, 13, 37, 45 etc.

The system receiver have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shift frequencies in synchronization with the transmitted signals.



6. Quantity of Hopping Channels and Channel Separation

6.1 Standard Applicable

According to FCC 15.247(a)(1), frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, and frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.

6.2 Test Procedure

According to the DA 00-705, the number of hopping frequencies test method as follows.

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings: Span = the frequency band of operation $RBW \ge 1\%$ of the span $VBW \ge RBW$ Sweep = auto Detector function = peak Trace = max hold Allow the trace to stabilize, observed the band of 2400MHz to 2483.5MHz, than count it out the number of channels for comparing with the FCC rules.

The channel spacing test method as follows:

Span = wide enough to capture the peaks of two adjacent channels Resolution (or IF) Bandwidth (RBW) $\geq 1\%$ of the span Video (or Average) Bandwidth (VBW) $\geq RBW$ Sweep = auto Detector function = peak Trace = max hold

Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section. Submit this plot.

6.3 Environmental Conditions

Temperature:	24 °C
Relative Humidity:	54%
ATM Pressure:	1011 mbar

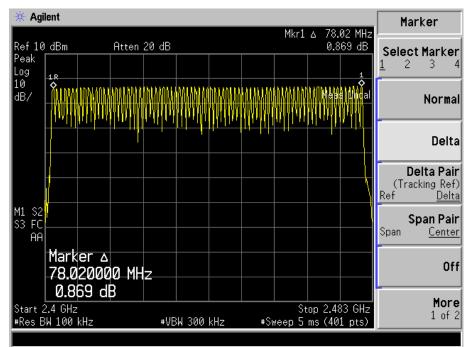


6.4 Summary of Test Results/Plots

Frequency B	uency Band Number of I		Hopping Frequencies (N)		Limit	Result
2400-2483.51	2400-2483.5MHz		79		15	Passed
	Test	Channel	Adjacent Channel	Ch	annel Separation	Limit
Test Mode	Test Mode		MHz		MHz	MHz
		2402	2403		1.005	>0.025
GFSK	GFSK		2442		1.005	>0.025
		2480	2479		1.00625	>0.025
		2402	2403		1.005	>0.025
8DPSK		2441	2442		1.005	>0.025
		2480	2479		1.00628	>0.025

Test plots please refer to below:

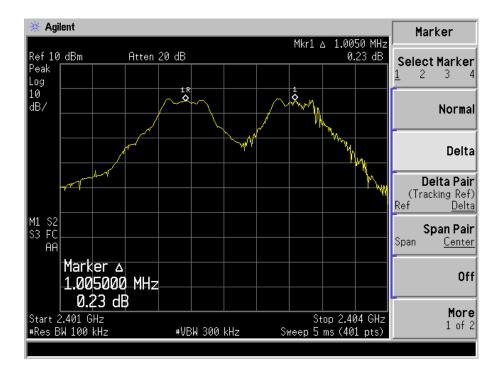
No. of Channel = 79



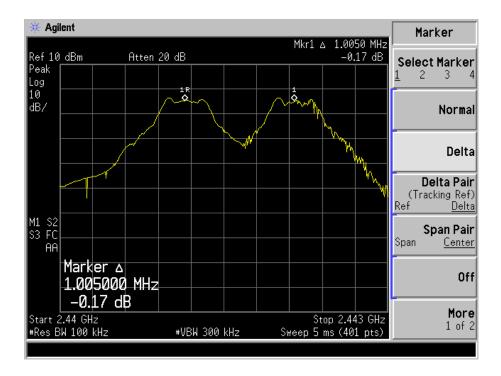


For GFSK mode

Channel Spacing (Low CH=1MHz)

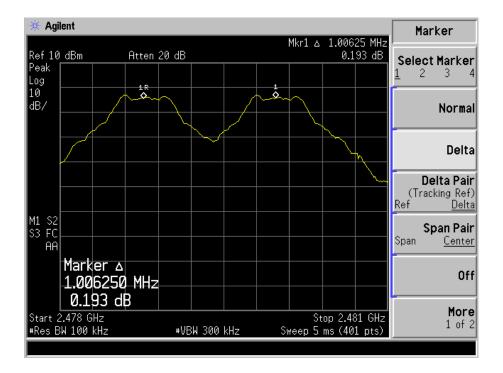


Channel Spacing (Middle CH=1MHz)

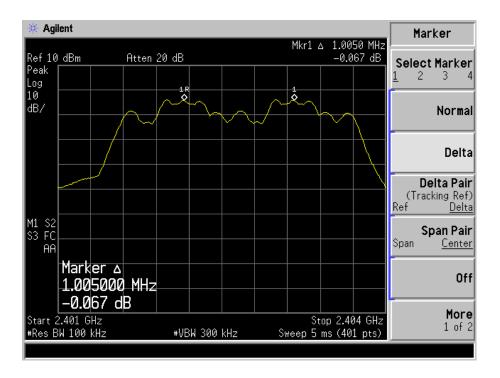




Channel Spacing (High CH=1MHz)

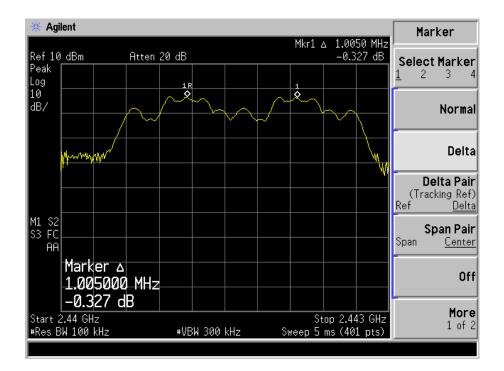


For 8DPSK mode Channel Spacing (Low CH=1MHz)

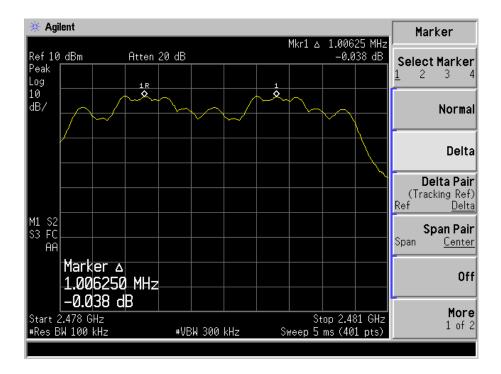




Channel Spacing (Middle CH=1MHz)



Channel Spacing (High CH=1MHz)





7. Dwell Time of Hopping Channel

7.1 Standard Applicable

According to 15.247(a)(1)(iii), Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

7.2 Test Procedure

According to the DA 00-705, the dwell time of a hopping channel test method as follows.

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.

Span = zero span, centered on a hopping channel

RBW = 1 MHz

 $VBW \ge RBW$

Sweep = as necessary to capture the entire dwell time per hopping channel

Detector function = peak

Trace = max hold

Use the marker-delta function to determine the dwell time

7.3 Environmental Conditions

Temperature:	24 °C
Relative Humidity:	54%
ATM Pressure:	1011 mbar



7.4 Summary of Test Results/Plots

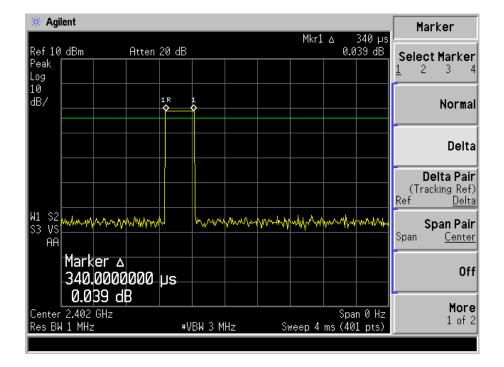
The dwell time within a period in data mode is independent from the packet type (packet length). Test data is corrected with the worse case, which the packet length is DH1, DH3, and DH5.

The test period: T = 0.4 Second * 79 Channel = 31.6 s Dwell time = time slot length * (Hopping rate / Number of hopping channels) * Period

Madulation	Test Channel	Dealast	Time Slot Length	Dwell Time	Limit
Modulation	Test Channel	Packet	ms	ms	ms
		DH1	0.34	108.800	400
	2402MHz	DH3	1.60	256.000	400
		DH5	2.86	305.067	400
		DH1	0.36	115.200	400
GFSK	2441MHz	DH3	1.62	259.200	400
		DH5	2.85	304.000	400
	2480MHz	DH1	0.35	112.000	400
		DH3	1.62	259.200	400
		DH5	2.86	305.067	400
	2402MHz	3DH1	0.38	121.600	400
		3DH3	1.62	259.200	400
		3DH5	2.87	306.133	400
		3DH1	0.36	115.200	400
8DPSK	2441MHz	3DH3	1.62	259.200	400
		3DH5	2.88	307.200	400
		3DH1	0.36	115.200	400
	2480MHz	3DH3	1.61	257.600	400
		3DH5	2.85	304.000	400

Please refer to the test plots as below:

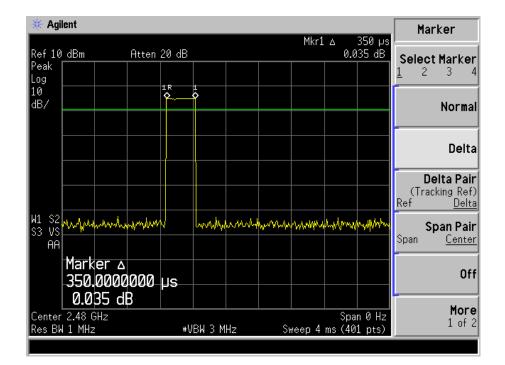




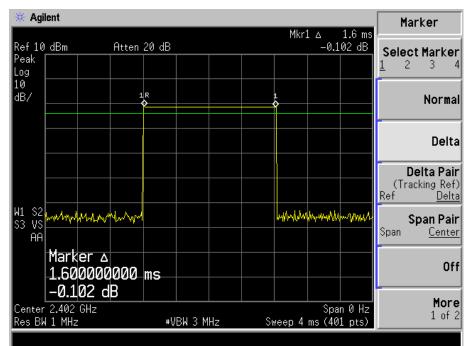
DH1 time slot (Low, Middle, High Channels)

🔆 Agil	ent						M I 4		200	Marker
Ref 10 Peak Log	dBm	Atten 3	20 dB				Mkr1		360 µs 093 dB	Select Marker <u>1</u> 2 3 4
10 dB/			1 R	1 \$						Normal
										Delta
										Delta Pair (Tracking Ref) Ref <u>Delta</u>
W1 S2 S3 VS AA	haddenlayarmadik	May April 1944	'n	howard	www.	ntref many	Verhannen	ww	w MAn	Span Pair Span <u>Center</u>
	Marker △ 360.0000	1000	µs							Off
Center Res BW	- 0.093 d 2.441 GHz 1 MHz	В	#V	BW 3 M	IHz	Sı	veep 4		an 0 Hz 01 pts)	More 1 of 2

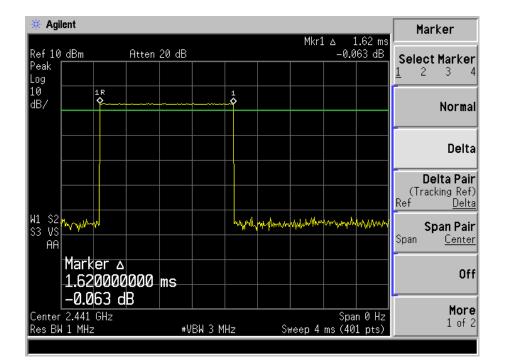


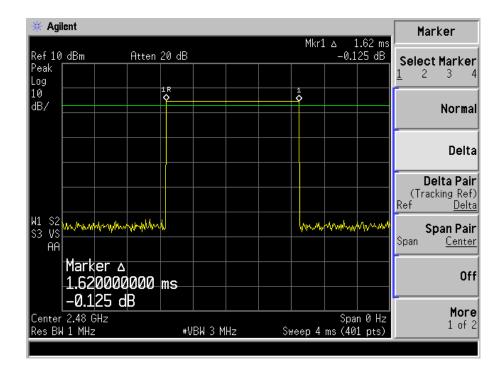


DH3 time slot (Low, Middle, High Channels)

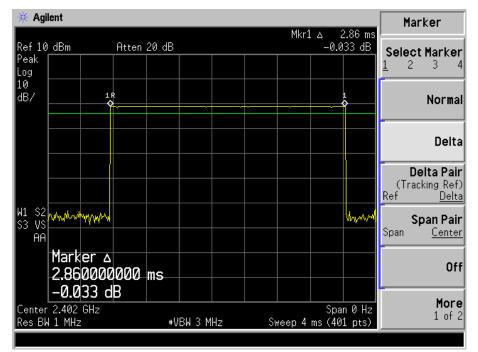




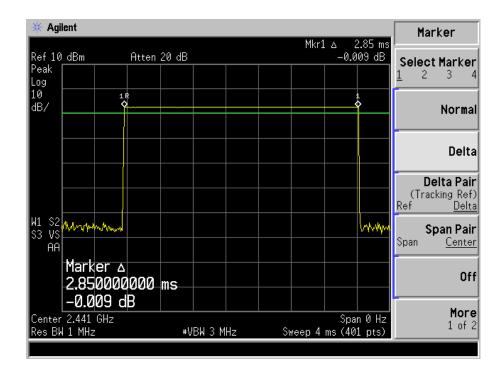




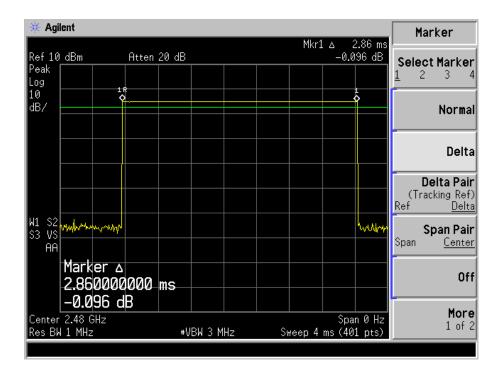




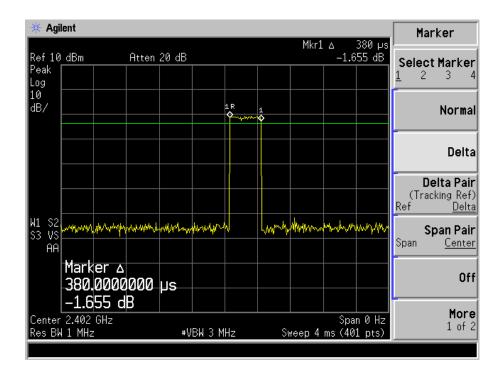
DH5 time slot (Low, Middle, High Channels)





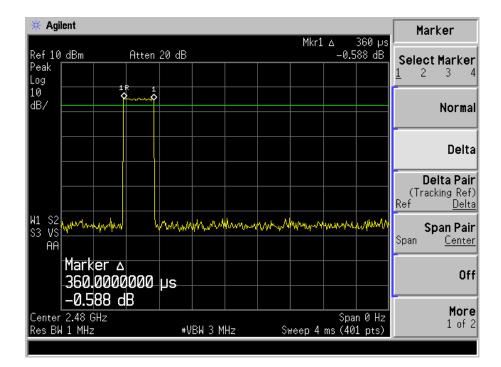


3DH1 time slot (Low, Middle, High Channels)

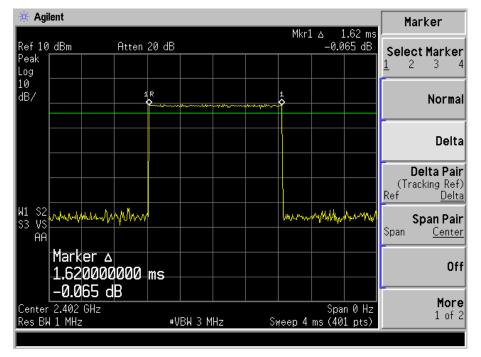




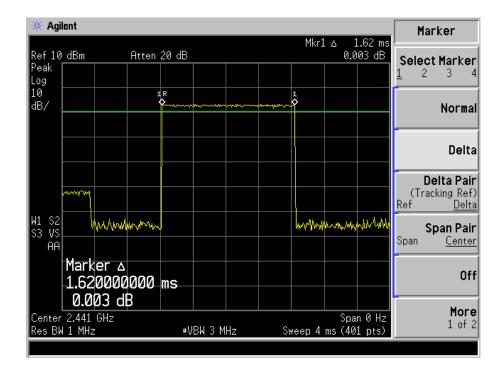
🔆 Agilent				[Marker
Ref 10 dBm	Atten 20 dB			360 µs 353 dB	Select Marker
Peak Log					<u>1</u> 2 3 4
10 dB/	1R 1 0				Norma
					Delta
					Delta Pai (Tracking Ref Ref Delt
41 S2 S3 VS AA	nd hyphran	ht when the	mannaphron	W~~~~	Span Pai Span <u>Cente</u>
Marker	00000 µs				Of
Center 2.441 GHz Res BW 1 MHz		/BW 3 MHz	Spa Sweep 4 ms (40	n 0 Hz 1 pts)	More 1 of 3



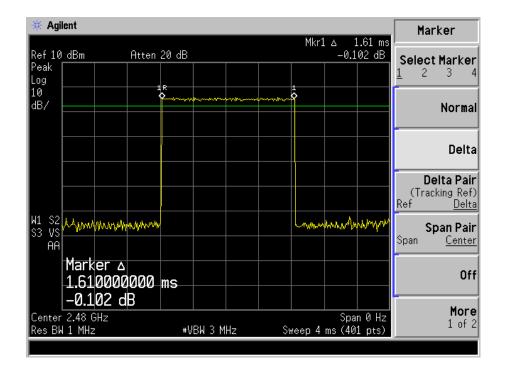




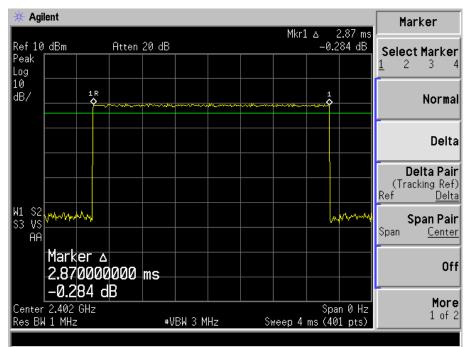
3DH3 time slot (Low, Middle, High Channels)



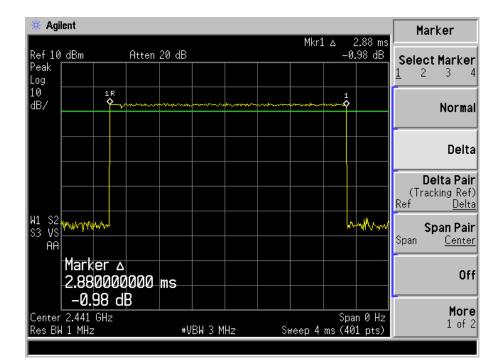


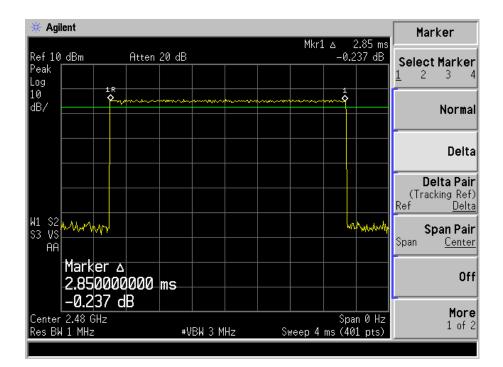


3DH5 time slot (Low, Middle, High Channels)











8. 20dB Bandwidth

8.1 Standard Applicable

According to 15.247(a) and 15.215(c). 20dB bandwidth is recommended that the fundamental emission be kept within at least the central 80% of the permitted band in order to minimize the possibility of out-of-band operation.

8.2 Test Procedure

According to the DA 00-705, the 20dB bandwidth test method as follows.

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.

Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel

 $RBW \ge 1\%$ of the 20 dB bandwidth

 $VBW \ge RBW$

Sweep = auto; Detector function = peak

Trace = max hold

All the trace to stabilize, use the marker-to-peak function to set the marker to the peak of the emission, use the marker-delta function to measure and record the 20dB down bandwidth of the emission.

8.3 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	53%
ATM Pressure:	1018 mbar

8.4 Summary of Test Results/Plots

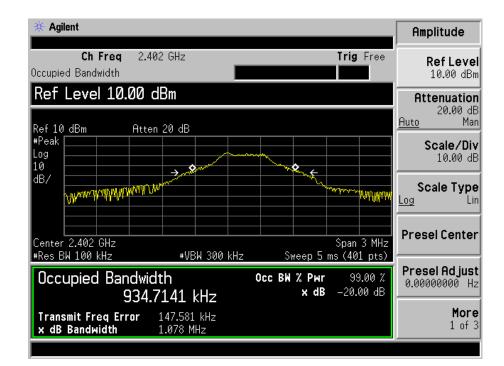
Test Mode	Test Channel MHz	20 dB Bandwidth kHz	99% Bandwidth kHz	Result
	2402	1078	934.7141	Pass
GFSK	2441	1087	950.8779	Pass
	2480	1065	921.3438	Pass
	2402	1337	1205.6	Pass
8DPSK	2441	1338	1208.6	Pass
	2480	1341	1193.4	Pass



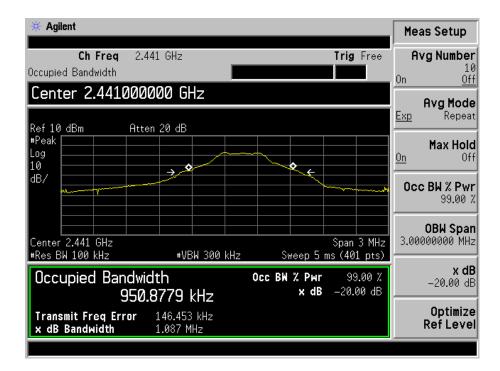


For GFSK

Low Channel:

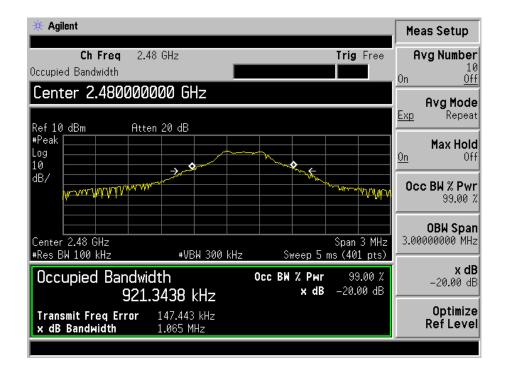


Middle Channel:

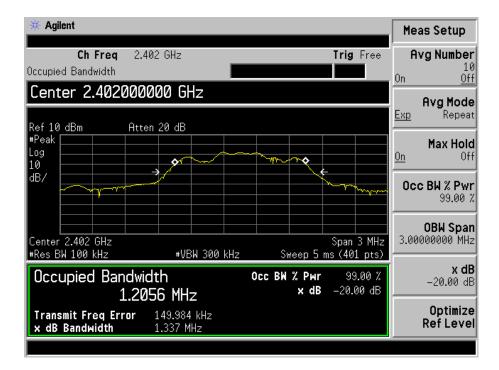




High Channel:

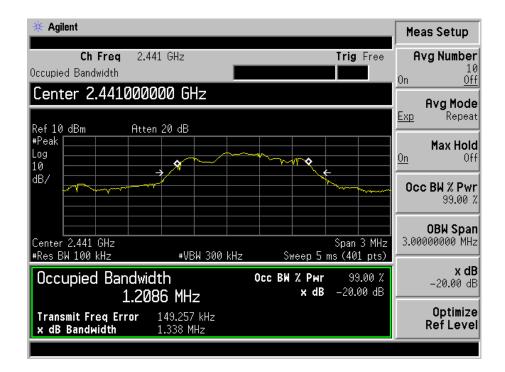


For 8DPSK Low Channel:

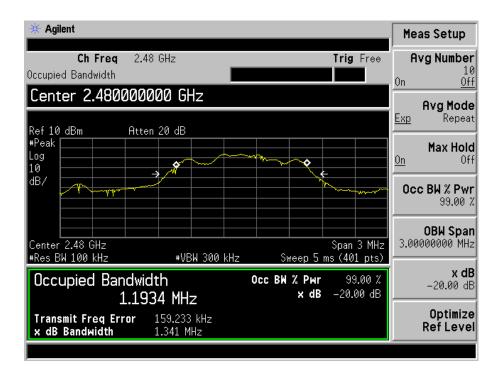




Middle Channel:



High Channel:





9. RF Output Power

9.1 Standard Applicable

According to 15.247(b)(1). For frequency hopping systems operating in the 2400–2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725–5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400–2483.5 MHz band: 0.125 watts.

9.2 Test Procedure

According to the DA 00-705, the peak output power test method as follows.

Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

RBW > the 20 dB bandwidth of the emission being measured

 $VBW \ge RBW$

Sweep = auto

Detector function = peak

Trace = max hold

All the trace to stabilize, use the marker-to-peak function to set the marker to the peak of the emission, the indicated level is the peak output power (the external attenuation and cable loss shall be considered).

9.3 Environmental Conditions

Temperature:	24 °C
Relative Humidity:	55%
ATM Pressure:	1011 mbar

9.4 Summary of Test Results/Plots



For GFSK

Channel	Frequency MHz	Measured Value dBm	Output Power mW	Limit mW
Low Channel	2402	-4.054	0.39	1000
Middle Channel	2441	-3.536	0.44	1000
High Channel	2480	-3.198	0.48	1000

For Pi/4 QDPSK

Channel	Frequency MHz	Measured Value dBm	Output Power mW	Limit mW
Low Channel	2402	-3.309	0.47	1000
Middle Channel	2441	-2.641	0.54	1000
High Channel	2480	-2.387	0.58	1000

For 8DPSK

Channel	Frequency	Frequency Measured Value		Limit
Channel	MHz	dBm	mW	mW
Low Channel	2402	-2.658	0.54	1000
Middle Channel	2441	-2.089	0.62	1000
High Channel	2480	-1.833	0.66	1000

Note: the antenna gain of 0dBi less than 6dBi maximum permission antenna gain value based on 1 watt peak output power limit.



10. Field Strength of Spurious Emissions

10.1 Standard Applicable

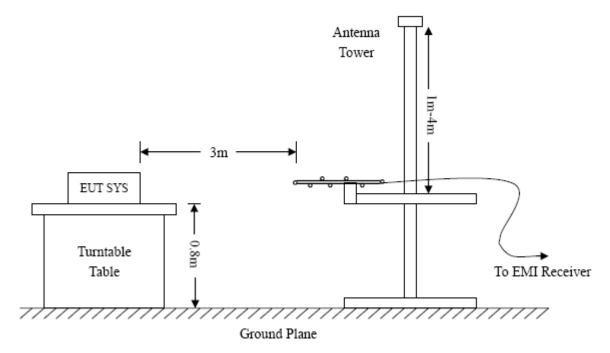
According to §15.247(d), in any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.209(a), must also comply with the radiated emission limits specified in §15.209(a).

The emission limit in this paragraph is based on measurement instrumentation employing an average detector. The provisions in §15.35 for limiting peak emissions apply. Spurious Radiated Emissions measurements starting below or at the lowest crystal frequency.

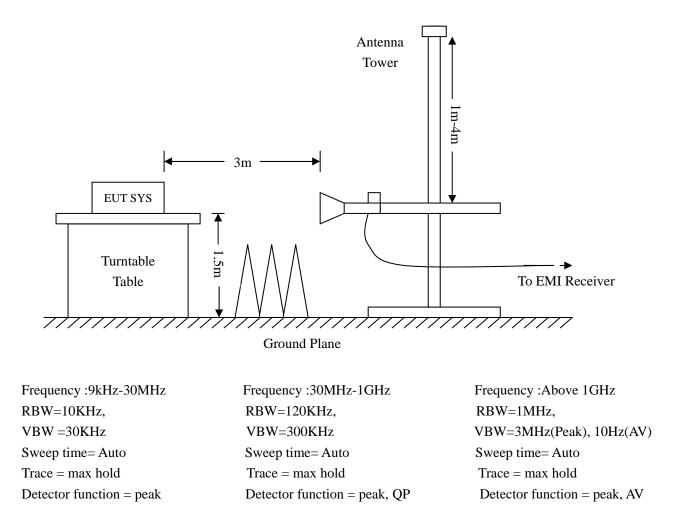
10.2 Test Procedure

The setup of EUT is according with per ANSI C63.4-2014 measurement procedure. The specification used was with the FCC Part 15.205 15.247(a) and FCC Part 15.209 Limit.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle. The spacing between the peripherals was 10 cm.







10.3 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading + Ant. Factor + Cable Loss – Ampl. Gain

The "**Margin**" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of $-6dB\mu V$ means the emission is $6dB\mu V$ below the maximum limit. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – FCC Part 15 Limit

10.4 Environmental Conditions

Temperature:	25 °C
Relative Humidity:	52%
ATM Pressure:	1012 mbar



10.5 Summary of Test Results/Plots

According to the data below, the FCC Part 15.205, 15.209 and 15.247 standards, and had the worst cases:

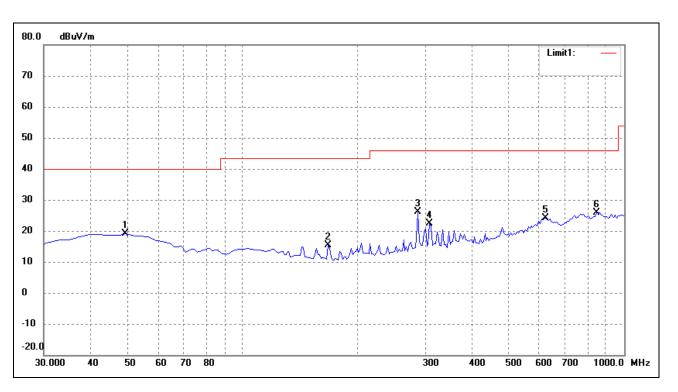
Note: this EUT was tested in 3 orthogonal positions and the worst case position data was reported.

Plot of Radiated Emissions Test Data (30MHz to 1GHz)

EUT:	Car Radio
Tested Model:	VR-651B
Operating Condition:	Transmitting Low Channel (2402MHz)
Comment:	DC 12V For battery

Horizontal

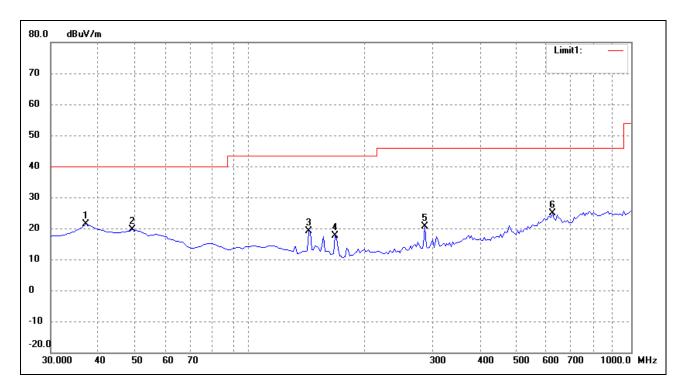
Test Specification:



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	49.4000	27.44	-8.28	19.16	40.00	-20.84	214	100	peak
2	168.2250	27.22	-11.90	15.32	43.50	-28.18	336	100	peak
3	289.4750	31.99	-5.89	26.10	46.00	-19.90	272	100	peak
4	311.3000	27.33	-5.07	22.26	46.00	-23.74	100	100	peak
5	624.1250	22.99	1.13	24.12	46.00	-21.88	100	100	peak
6	852.0750	23.30	2.52	25.82	46.00	-20.18	100	100	peak



Test Specification: Vertical



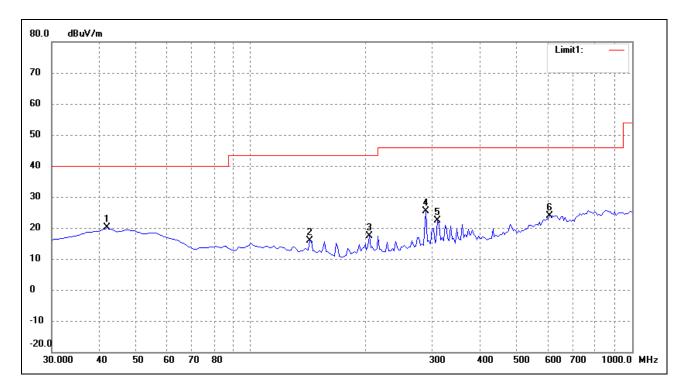
No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	37.2750	29.73	-8.41	21.32	40.00	-18.68	360	100	peak
2	49.4000	27.80	-8.28	19.52	40.00	-20.48	360	100	peak
3	143.9750	31.68	-12.50	19.18	43.50	-24.32	178	100	peak
4	168.2250	29.48	-11.90	17.58	43.50	-25.92	100	100	peak
5	289.4750	26.47	-5.89	20.58	46.00	-25.42	100	100	peak
6	624.1250	23.67	1.13	24.80	46.00	-21.20	100	100	peak



Operating Condition:	Transmitting Middle Channel (2441MHz)
Comment:	DC 12V

Test Specification:

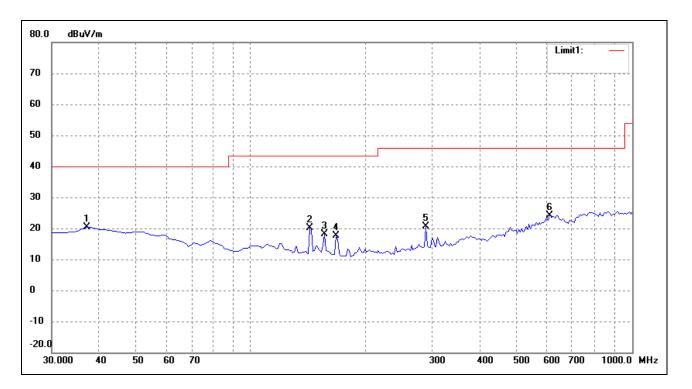
Horizontal



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	42.1250	27.82	-7.81	20.01	40.00	-19.99	360	100	peak
2	143.9750	28.47	-12.50	15.97	43.50	-27.53	275	100	peak
3	204.6000	26.17	-8.69	17.48	43.50	-26.02	360	100	peak
4	289.4750	31.34	-5.89	25.45	46.00	-20.55	100	100	peak
5	311.3000	27.34	-5.07	22.27	46.00	-23.73	100	100	peak
6	612.0000	23.25	0.68	23.93	46.00	-22.07	100	100	peak



Test Specification: Vertical



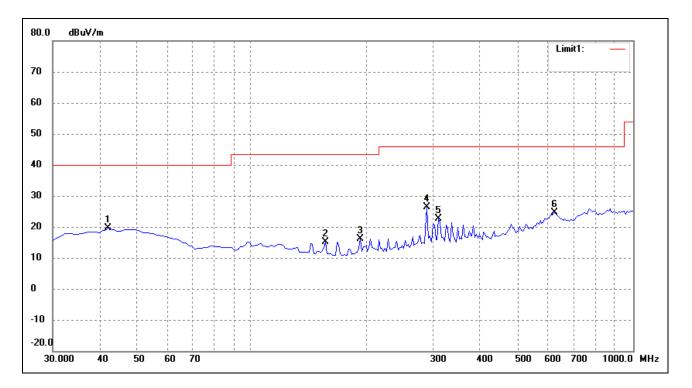
No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	37.2750	28.87	-8.41	20.46	40.00	-19.54	360	100	peak
2	143.9750	32.59	-12.50	20.09	43.50	-23.41	226	100	peak
3	156.1000	30.56	-12.33	18.23	43.50	-25.27	360	100	peak
4	168.2250	29.56	-11.90	17.66	43.50	-25.84	100	100	peak
5	289.4750	26.60	-5.89	20.71	46.00	-25.29	100	100	peak
6	612.0000	23.57	0.68	24.25	46.00	-21.75	100	100	peak



Operating Condition:	Transmitting High Channel (2480MHz)
Comment:	DC 12V

Test Specification:

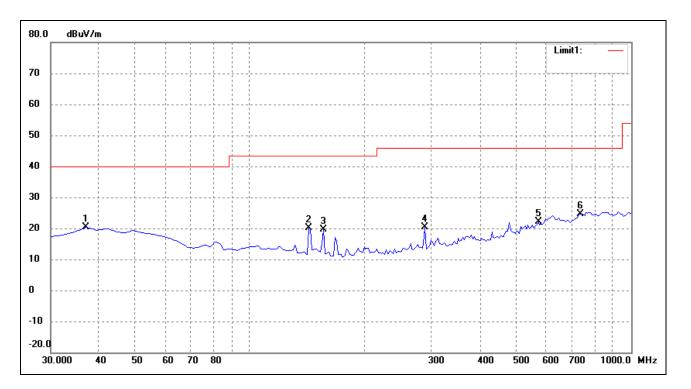
Horizontal



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	42.1250	27.36	-7.81	19.55	40.00	-20.45	336	100	peak
2	156.1000	27.47	-12.33	15.14	43.50	-28.36	360	100	peak
3	192.4750	25.84	-9.67	16.17	43.50	-27.33	360	100	peak
4	289.4750	32.25	-5.89	26.36	46.00	-19.64	100	100	peak
5	311.3000	27.67	-5.07	22.60	46.00	-23.40	100	100	peak
6	624.1250	23.42	1.13	24.55	46.00	-21.45	100	100	peak



Test Specification: Vertical



No.	Frequency	Reading	Correct	Result	Limit	Margin	Degree	Height	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	(°)	(cm)	
1	37.2750	28.81	-8.41	20.40	40.00	-19.60	105	100	peak
2	143.9750	32.64	-12.50	20.14	43.50	-23.36	100	100	peak
3	156.1000	31.92	-12.33	19.59	43.50	-23.91	100	100	peak
4	289.4750	26.19	-5.89	20.30	46.00	-25.70	100	100	peak
5	575.6250	23.23	-1.05	22.18	46.00	-23.82	100	100	peak
6	738.1000	22.62	2.02	24.64	46.00	-21.36	100	100	peak



Frequency	Reading	Correct	Result	Limit	Margin	Polar	Detector
(MHz)	(dBuV)	dB/m	(dBuV/m)	(dBuV/m)	(dB)	H/V	
			Low Channe	el-2402MHz			
4804	55.94	-3.59	52.35	74	-21.65	Н	РК
4804	44.82	-3.59	41.23	54	-12.77	Н	AV
7206	50.82	-0.52	50.30	74	-23.70	Н	РК
7206	40.36	-0.52	39.84	54	-14.16	Н	AV
4804	56.72	-3.59	53.13	74	-20.87	V	РК
4804	45.89	-3.59	42.30	54	-11.70	V	AV
7206	51.99	-0.52	51.47	74	-22.53	V	РК
7206	44.35	-0.52	43.83	54	-10.17	V	AV
			Middle Chan	nel-2441MHz			
4882	57.36	-3.49	53.87	74	-20.13	Н	РК
4882	46.14	-3.49	42.65	54	-11.35	Н	AV
7323	50.60	-0.47	50.13	74	-23.87	Н	РК
7323	41.12	-0.47	40.65	54	-13.35	Н	AV
4882	53.83	-3.49	50.34	74	-23.66	V	РК
4882	43.59	-3.49	40.10	54	-13.90	V	AV
7323	51.78	-0.47	51.31	74	-22.69	V	РК
7323	41.58	-0.47	41.11	54	-12.89	V	AV
			High Chann	el-2480MHz			
4960	56.62	-3.41	53.21	74	-20.79	Н	РК
4960	45.61	-3.41	42.20	54	-11.80	Н	AV
7440	50.87	-0.42	50.45	74	-23.55	Н	РК
7440	42.02	-0.42	41.60	54	-12.40	Н	AV
4960	54.66	-3.41	51.25	74	-22.75	V	РК
4960	44.54	-3.41	41.13	54	-12.87	V	AV
7440	52.72	-0.42	52.30	74	-21.70	V	РК
7440	41.32	-0.42	40.90	54	-13.10	V	AV

Spurious Emissions Above 1GHz

Note: Testing is carried out with frequency rang 9kHz to the tenth harmonics, other than listed in the table above are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.



11. Out of Band Emissions

11.1 Standard Applicable

According to §15.247 (d) In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a).

11.2 Test Procedure

According to the DA 00-705, the band-edge radiated test method as follows.

Set span = wide enough to capture the peak level of the emission operating on the channel closest to the bandedge, as well as any modulation products which fall outside of the authorized band of operation (2310MHz to 2410MHz for low bandedge, 2470MHz to 2500MHz for the high bandedge) RBW = 1MHz, VBW = 1MHz for peak value measured RBW = 1MHz, VBW = 10Hz for average value measured Sweep = auto; Detector function = peak; Trace = max hold

All the trace to stabilize, set the marker on the emission at the bandedge, or on the highest modulation porduct outside of the band, if this level is greater than that at the bandedge. Enable the marker-delta function, then use the marker-to-peak function to move the marker to the peak of the in-band emission. Those emission must comply with the 15.209 limit for fall in the restricted bands listed in section 15.205. Note that the method of measurement KDB publication number: 913591 may be used for the radiated bandedge measurements.

According to the DA 00-705, the band-edge conducted test method as follows:

Set span = wide enough to capture the peak level of the emission operating on the channel closest to the bandedge, as well as any modulation products which fall outside of the authorized band of operation (2380MHz to 2410MHz for low bandedge, 2470MHz to 2500MHz for the high bandedge) RBW = 100kHz, VBW = 300kHz Sweep = auto; Detector function = peak; Trace = max hold

All the trace to stabilize, set the marker on the emission at the bandedge, or on the highest modulation porduct outside of the band, if this level is greater than that at the bandedge. Enable the marker-delta function, then use the marker-to-peak function to move the marker to the peak of the in-band emission. Those emission must comply with the limit specified in this section (at least 20dB attenuation).

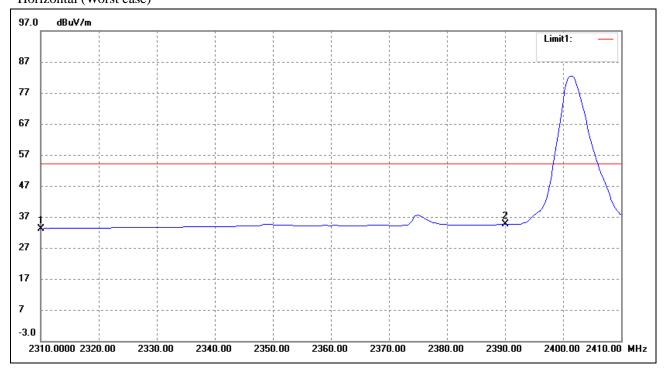


11.3 Environmental Conditions

Temperature:	23°C
Relative Humidity:	54%
ATM Pressure:	1011 mbar

11.4 Summary of Test Results/Plots

Bandedge (Radiated) Lowest Bandedge Horizontal (Worst case)

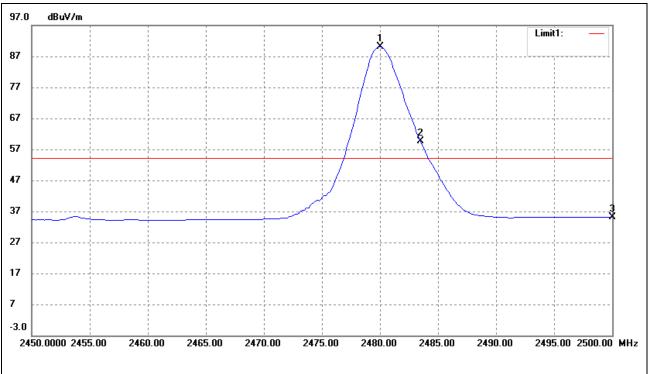


No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
1	2310.000	37.02	-3.80	33.22	54.00	-20.78	Average Detector
	2310.000	47.80	-3.80	44.00	74.00	-30.00	Peak Detector
2	2390.000	37.55	-3.00	34.55	54.00	-19.45	Average Detector
	2390.000	49.38	-3.00	46.38	74.00	-27.62	Peak Detector



Highest Bandedge

Horizontal (Worst case)

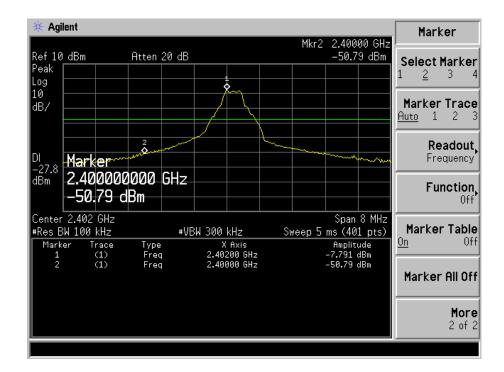


No.	Frequency	Reading	Correct	Result	Limit	Margin	Remark
	(MHz)	(dBuV)	(dB/m)	(dBuV/m)	(dBuV/m)	(dB)	
1	2480.000	92.58	-2.50	90.08	/	/	Average Detector
	2480.125	97.18	-2.50	94.68	/	/	Peak Detector
2	2483.500	Delta = 30.62 dBc		59.66	54.00	5.66	Average Detector
	2483.500			64.06	74.00	-9.94	Peak Detector
3	2500.000	37.42	-2.40	35.02	54.00	-18.98	Average Detector
	2500.000	48.07	-2.40	45.67	74.00	-28.33	Peak Detector

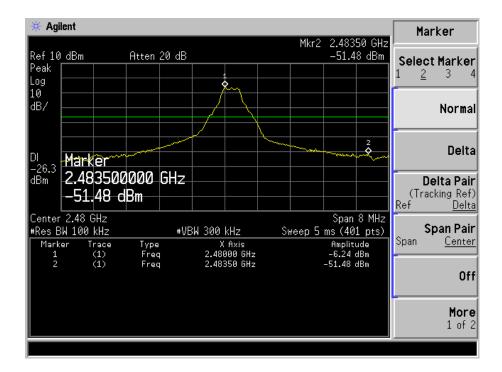


Bandedge (Conducted)

Lowest

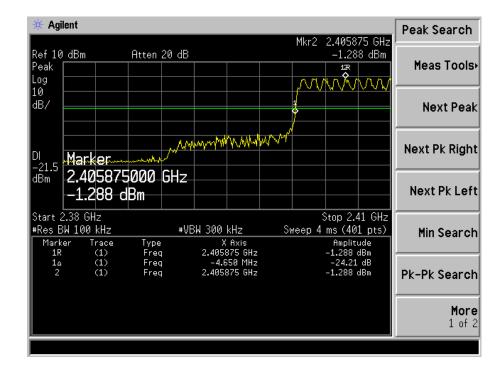


Highest

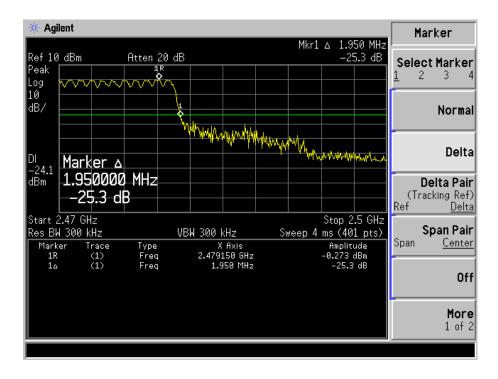




Hopping Bandedge (Conducted) Lowest Bandedge



Highest Bandedge



***** END OF REPORT *****